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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/717,279	11/19/2003	Steven J. Koester	YOR920030533US1 (17110)	7401	
23389 75	90 09/25/2006		EXAM	INER	
	OTT MURPHY & PRES	MAI, A	MAI, ANH D		
400 GARDEN CITY PLAZA SUITE 300			ART UNIT	PAPER NUMBER	
	GARDEN CITY, NY 11530			2814	
			DATE MAILED: 09/25/2006		

Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)			
	10/717,279	KOESTER, STEVEN J.			
Office Action Summary	Examiner	Art Unit			
	Anh D. Mai	2814			
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply					
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tirr will apply and will expire SIX (6) MONTHS from a cause the application to become ABANDONE	N. nely filed the mailing date of this communication. D (35 U.S.C. § 133).			
Status					
 1) ⊠ Responsive to communication(s) filed on 26 Ju 2a) ☐ This action is FINAL. 2b) ⊠ This 3) ☐ Since this application is in condition for allowar closed in accordance with the practice under E 	action is non-final. nce except for formal matters, pro				
Disposition of Claims					
4) Claim(s) 1,2 and 4-21 is/are pending in the app 4a) Of the above claim(s) 10-21 is/are withdraw 5) Claim(s) is/are allowed. 6) Claim(s) 1,2 and 4-9 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and/or	n from consideration.				
Application Papers					
9) The specification is objected to by the Examine 10) The drawing(s) filed on is/are: a) access Applicant may not request that any objection to the of Replacement drawing sheet(s) including the correct of the oath or declaration is objected to by the Examine	epted or b) objected to by the fidening of behind on by the fidening of behind in abeyance. See ion is required if the drawing(s) is obj	e 37 CFR 1.85(a). jected to. See 37 CFR 1.121(d).			
Priority under 35 U.S.C. § 119					
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 					
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date	4) Interview Summary Paper No(s)/Mail Da 5) Notice of Informal P 6) Other:	ate			

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DETAILED ACTION

Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on June 26, 2006 has been entered.

Status of the Claims

2. Amendment filed June 26, 2006 has been entered. Claim 3, has been cancelled. Claims 1 and 4 have been amended. Non-elected invention, claims 10-21 have been withdrawn. Claims 1, 2 and 4-21 are pending.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.
- 3. Claims 1, 2, 4 and 7-9 are rejected under 35 U.S.C. 102(e) as being anticipated by Xiang (U.S. Patent No. 6,749,527).

With respect to claim 1, Xiang teaches a semiconductor field-effect transistor device as claimed including:

a first strained layer (42) of semiconductor material doped of a first dopant type formed on a substrate (40);

a source region and a drain region (64) implanted with dopants of a second opposite type; a gate electrode (54) separated from the first layer (42) by a dielectric region (56), and positioned between the source and drain regions (64);

substrate (40) inherently having one or more dislocation or crystal defects that extends continuously from the source region to the drain region (64) at the interface between the first strained layer (42) of semiconductor material and substrate (40), and

blocking impurity dopant materials that partially or fully occupies each one or more dislocation or crystal defects, wherein the blocking impunity dopant materials substantially inhibit diffusion of the implanted source and drain dopants from diffusing along the dislocations or crystal defect (185). (See Fig. 3i).

With respect to claim 2, the first strained layer (42) of semiconductor material of Xiang comprises material selected from the group comprising Si.

With respect to claim 4, the semiconductor substrate (40) of Xiang includes a SiGe relaxed substrate.

With respect to claim 7, the blocking impurity of Xiang is a neutral-type impurity.

With respect to claim 8, the blocking impurity of Xiang is a group IV impurity.

With respect to claim 9, the blocking impurity of Xiang is C.

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Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

- (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. Claims 5 and 6 are rejected under 35 U.S.C. 103(a) as being unpatentable over Xiang '527 as applied to claim 1 above, and further in view of Noda et al. (U.S. Patent No. 6,432,802), of record.

Xiang teaches that halo region are doped with dopant of opposite the conductivity to the source and drain regions are formed.

Thus, Xiang is shown to teach all the features of the claim with the exception of explicitly disclosing the specific impurity for the halo region.

However, Noda teaches that it is well known in the art to form the halo region utilizing indium (In) for p-channel device and antimony (Sb) for n-channel device.

Therefore, it would have been obvious to one having ordinary skill in the art at the time of invention was made to form the halo blocking region of Xiang utilizing In or Sb blocking impurity as taught by Noda to prevent diffusion of the source/drain dopants into the channel region.

Note that, P, As or Sb as well as B or In, are well known in the art to be used for source/drain dopant in a p-channel or n-channel device, respectively.

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Response to Arguments

5. Applicant's arguments with respect to amended claims have been considered but are moot in view of the new ground(s) of rejection.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Anh D. Mai whose telephone number is (571) 272-1710. The examiner can normally be reached on 8:00AM-5:00PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Wael Fahmy can be reached on (571) 272-1705. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

PRIMARY EXAMINER